

# RJF0610JSP

60V , 1.5A Silicon N channel Thermal FET  
Power Switching

R07DS0568EJ0301  
Rev.3.01  
Sep 06, 2016

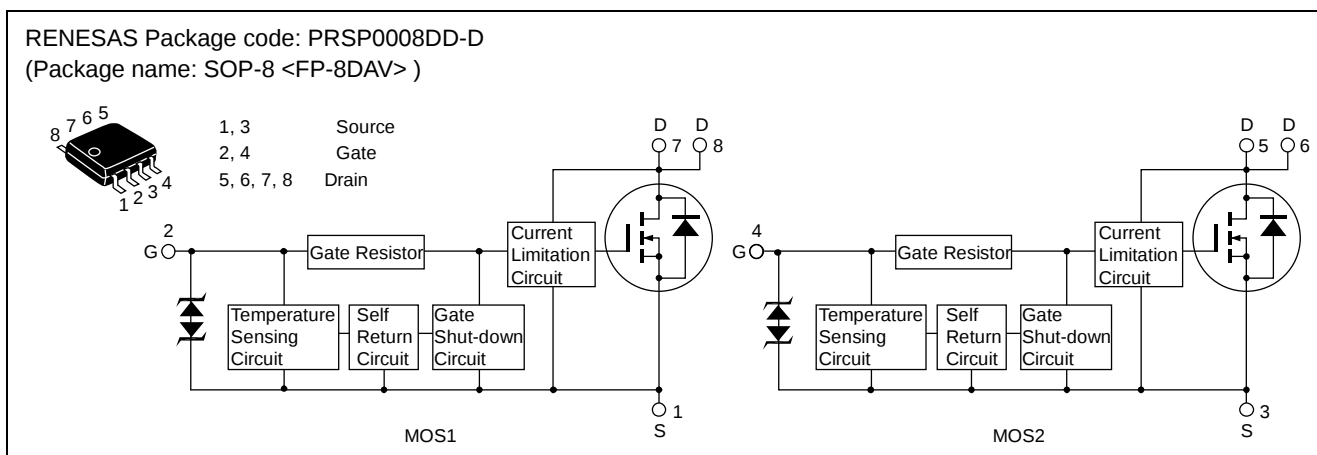
## Description

This FET has the over temperature shut-down capability sensing to the junction temperature. This FET has the built-in over temperature shut-down circuit in the gate area. And this circuit operation to shut-down the gate voltage in case of high junction temperature like applying over power consumption, over current etc..

## Features

- Logic level operation (5 to 6 V Gate drive).
- Built-in the over temperature shut-down circuit.
- High endurance capability against to the short circuit.
- Temperature hysteresis type.
- High density mounting
- Power supply voltage applies 12 V and 24 V.
- AEC-Q101 Compliant

## Outline



## Absolute Maximum Ratings

(Ta = 25°C)

| Item                                   | Symbol                     | Ratings     | Unit |
|----------------------------------------|----------------------------|-------------|------|
| Drain to source voltage                | $V_{DS}$                   | 60          | V    |
| Gate to source voltage                 | $V_{GS}$                   | 16          | V    |
| Gate to source voltage                 | $V_{GS}$                   | -2.5        | V    |
| Drain current                          | $I_D$ <sup>Note 4</sup>    | 1.5         | A    |
| Body-drain diode reverse drain current | $I_{DR}$                   | 1.5         | A    |
| Avalanche current                      | $I_{AP}$ <sup>Note 3</sup> | 0.95        | A    |
| Avalanche energy                       | $E_{AR}$ <sup>Note 3</sup> | 77.4        | mJ   |
| Channel dissipation                    | $P_{ch}$ <sup>Note 1</sup> | 2           | W    |
| Channel dissipation                    | $P_{ch}$ <sup>Note 2</sup> | 3           | W    |
| Channel temperature                    | $T_{ch}$                   | 150         | °C   |
| Storage temperature                    | $T_{stg}$                  | -55 to +150 | °C   |

- Notes: 1. 1 Drive operation: When using the glass epoxy board (FR4 40 × 40 × 1.6 mm),  $PW \leq 10$  s  
2. 2 Drive operation: When using the glass epoxy board (FR4 40 × 40 × 1.6 mm),  $PW \leq 10$  s  
3.  $T_{ch} = 25^\circ\text{C}$ ,  $R_g \geq 50 \Omega$ ,  $L = 100$  mH  
4. It provides by the current limitation lower bound value.

## Typical Operation Characteristics

(Ta = 25°C)

| Item                                        | Symbol               | Min | Typ  | Max | Unit | Test Conditions                                                 |
|---------------------------------------------|----------------------|-----|------|-----|------|-----------------------------------------------------------------|
| Input voltage                               | V <sub>IH</sub>      | 3.5 | —    | —   | V    |                                                                 |
|                                             | V <sub>IL</sub>      | —   | —    | 1.2 | V    |                                                                 |
| Input current<br>(Gate non shut down)       | I <sub>IH1</sub>     | —   | —    | 100 | μA   | V <sub>i</sub> = 5 V, V <sub>DS</sub> = 0                       |
|                                             | I <sub>IH2</sub>     | —   | —    | 50  | μA   | V <sub>i</sub> = 3.5 V, V <sub>DS</sub> = 0                     |
|                                             | I <sub>IL</sub>      | —   | —    | 1   | μA   | V <sub>i</sub> = 1.2 V, V <sub>DS</sub> = 0                     |
| Input current<br>(Gate shut down)           | I <sub>IH(sd)1</sub> | —   | 0.4  | —   | mA   | V <sub>i</sub> = 8 V, V <sub>DS</sub> = 0                       |
|                                             | I <sub>IH(sd)2</sub> | —   | 0.24 | —   | mA   | V <sub>i</sub> = 5 V, V <sub>DS</sub> = 0                       |
|                                             | I <sub>IH(sd)3</sub> | —   | 0.16 | —   | mA   | V <sub>i</sub> = 3.5 V, V <sub>DS</sub> = 0                     |
| Shut down temperature                       | T <sub>sd</sub>      | —   | 175  | —   | °C   | Channel temperature                                             |
| Return temperature                          | T <sub>hr</sub>      | —   | 120  | —   | °C   | Channel temperature                                             |
| Gate operation voltage                      | V <sub>op</sub>      | 3.5 | —    | 12  | V    |                                                                 |
| Drain current<br>(Current limitation value) | I <sub>D limit</sub> | 1.5 | —    | —   | A    | V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V <sup>Note 5</sup> |

Notes; 5. Pulse test

## Electrical Characteristics

(Ta = 25°C)

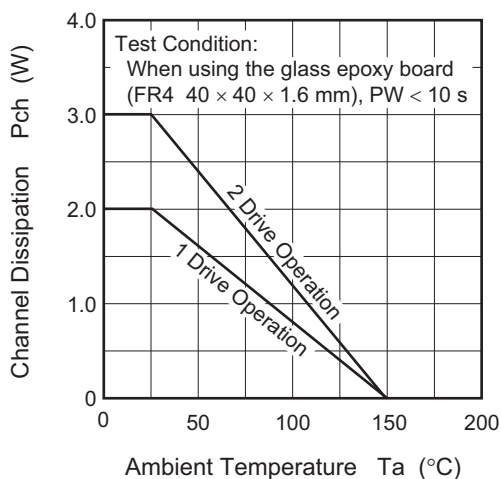
| Item                                                 | Symbol               | Min  | Typ  | Max  | Unit | Test Conditions                                                              |
|------------------------------------------------------|----------------------|------|------|------|------|------------------------------------------------------------------------------|
| Drain current                                        | I <sub>D1</sub>      | —    | —    | 2.4  | A    | V <sub>GS</sub> = 3.5 V, V <sub>DS</sub> = 2 V                               |
|                                                      | I <sub>D2</sub>      | —    | —    | 10   | mA   | V <sub>GS</sub> = 1.2 V, V <sub>DS</sub> = 2 V                               |
|                                                      | I <sub>D3</sub>      | 1.5  | —    | —    | A    | V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V <sup>Note 6</sup>              |
| Drain to source breakdown voltage                    | V <sub>(BR)DSS</sub> | 60   | —    | —    | V    | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0                                  |
| Gate to source breakdown voltage                     | V <sub>(BR)GSS</sub> | 16   | —    | —    | V    | I <sub>G</sub> = 500 μA, V <sub>DS</sub> = 0                                 |
|                                                      | V <sub>(BR)GSS</sub> | -2.5 | —    | —    | V    | I <sub>G</sub> = -100 μA, V <sub>DS</sub> = 0                                |
| Gate to source leak current                          | I <sub>GSS1</sub>    | —    | —    | 100  | μA   | V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 0                                   |
|                                                      | I <sub>GSS2</sub>    | —    | —    | 50   | μA   | V <sub>GS</sub> = 3.5 V, V <sub>DS</sub> = 0                                 |
|                                                      | I <sub>GSS3</sub>    | —    | —    | 1    | μA   | V <sub>GS</sub> = 1.2 V, V <sub>DS</sub> = 0                                 |
|                                                      | I <sub>GSS4</sub>    | —    | —    | -100 | μA   | V <sub>GS</sub> = -2.4 V, V <sub>DS</sub> = 0                                |
| Input current (shut down)                            | I <sub>GS(OP)1</sub> | —    | 0.4  | —    | mA   | V <sub>GS</sub> = 8 V, V <sub>DS</sub> = 0                                   |
|                                                      | I <sub>GS(OP)2</sub> | —    | 0.24 | —    | mA   | V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 0                                   |
|                                                      | I <sub>GS(OP)3</sub> | —    | 0.16 | —    | mA   | V <sub>GS</sub> = 3.5 V, V <sub>DS</sub> = 0                                 |
| Zero gate voltage drain current                      | I <sub>DSS1</sub>    | —    | —    | 10   | μA   | V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0                                  |
|                                                      | I <sub>DSS2</sub>    | —    | —    | 10   | μA   | V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0, Ta = 125°C                      |
| Gate to source cutoff voltage                        | V <sub>GS(off)</sub> | 1.4  | —    | 2.5  | V    | I <sub>D</sub> = 1 mA, V <sub>DS</sub> = 10 V                                |
| Static drain to source on state resistance           | R <sub>DS(on)</sub>  | —    | 207  | 285  | mΩ   | I <sub>D</sub> = 0.7 A, V <sub>GS</sub> = 5 V <sup>Note 6</sup>              |
|                                                      | R <sub>DS(on)</sub>  | —    | 153  | 214  | mΩ   | I <sub>D</sub> = 0.7 A, V <sub>GS</sub> = 10 V <sup>Note 6</sup>             |
| Output capacitance                                   | C <sub>oss</sub>     | —    | 267  | —    | pF   | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0, f = 1MHz                        |
| Turn-on delay time                                   | t <sub>d(on)</sub>   | —    | 4.3  | —    | μs   | I <sub>D</sub> = 0.7 A, V <sub>GS</sub> = 5 V, R <sub>L</sub> = 43 Ω         |
| Rise time                                            | t <sub>r</sub>       | —    | 18.3 | —    | μs   |                                                                              |
| Turn-off delay time                                  | t <sub>d(off)</sub>  | —    | 0.62 | —    | μs   |                                                                              |
| Fall time                                            | t <sub>f</sub>       | —    | 0.61 | —    | μs   |                                                                              |
| Body-drain diode forward voltage                     | V <sub>DF</sub>      | —    | 0.8  | —    | V    | I <sub>F</sub> = 1.5 A, V <sub>GS</sub> = 0                                  |
| Body-drain diode reverse recovery time               | t <sub>rr</sub>      | —    | 55   | —    | ns   | I <sub>F</sub> = 1.5 A, V <sub>GS</sub> = 0<br>di <sub>F</sub> /dt = 50 A/μs |
| Over load shut down operation time <sup>Note 7</sup> | t <sub>os1</sub>     | —    | 18   | —    | ms   | V <sub>GS</sub> = 5 V, V <sub>DD</sub> = 16 V                                |
|                                                      | t <sub>os2</sub>     | —    | 5.7  | —    | ms   | V <sub>GS</sub> = 5 V, V <sub>DD</sub> = 24 V                                |

Notes: 6. Pulse test

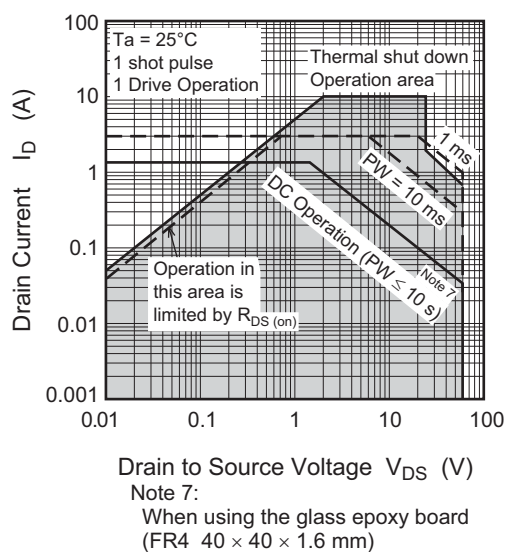
7. Including the junction temperature rise of the over loaded condition.

## Main Characteristics

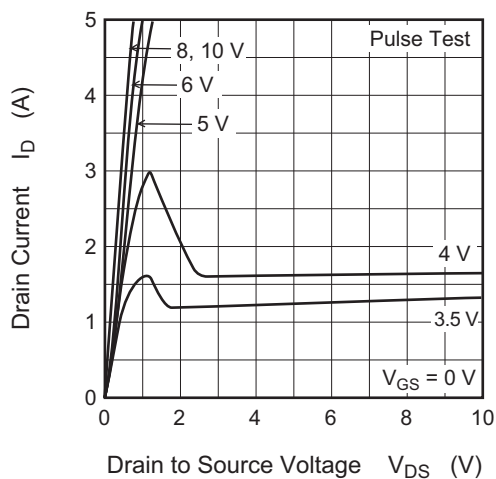
Power vs. Temperature Derating



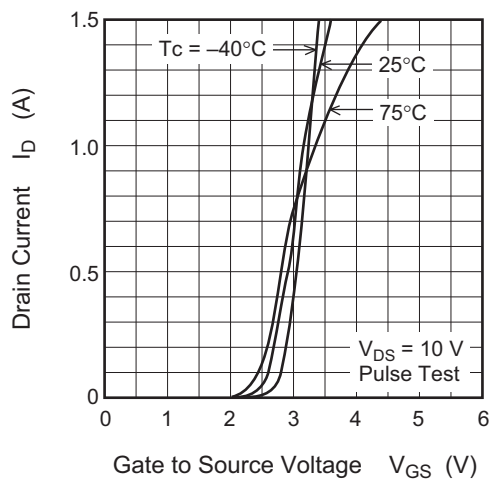
Maximum Safe Operation Area



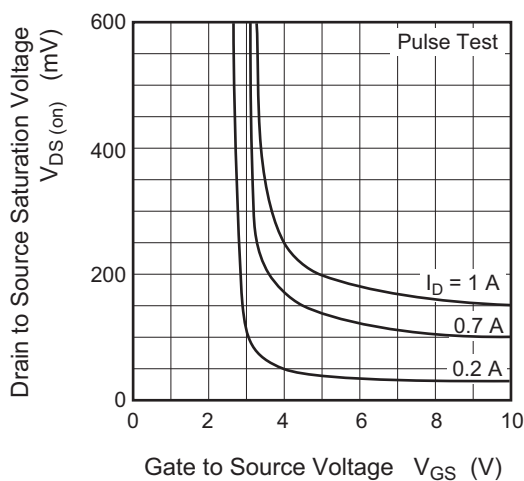
Typical Output Characteristics



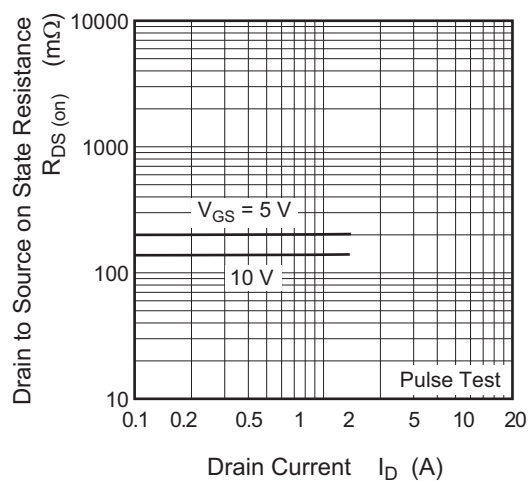
Typical Transfer Characteristics

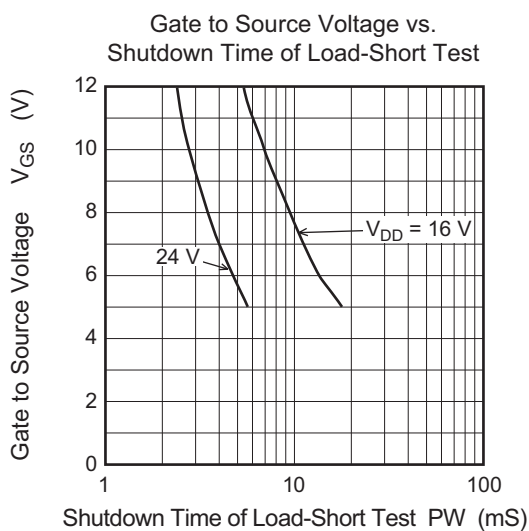
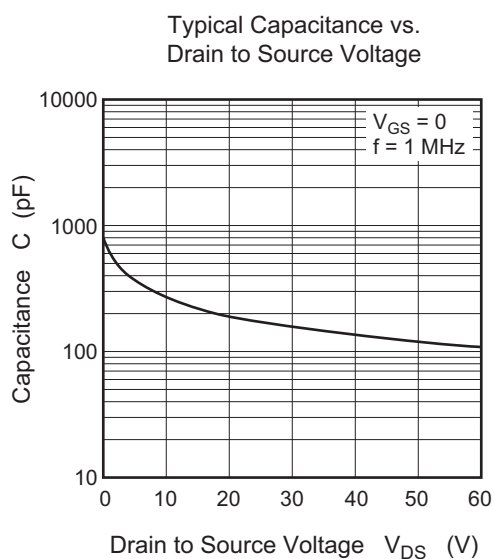
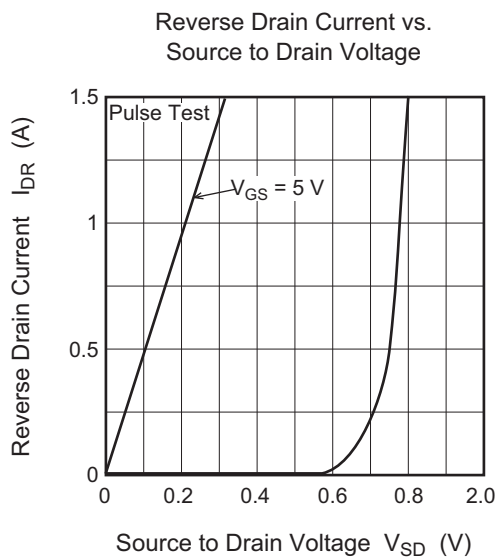
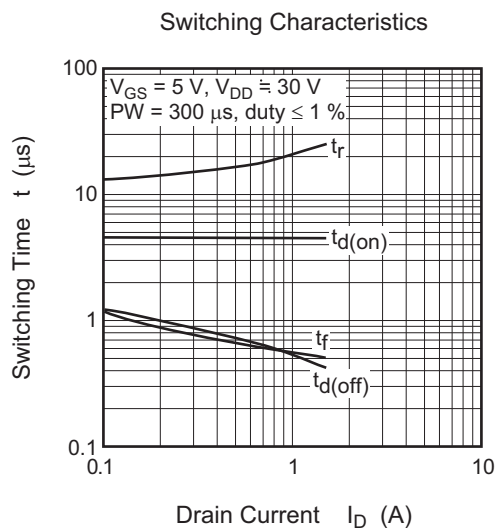
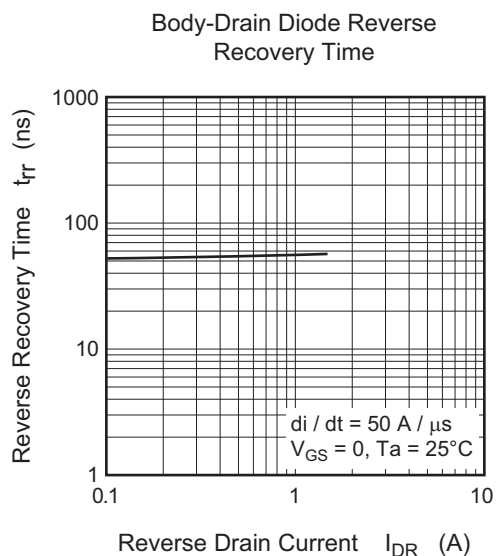
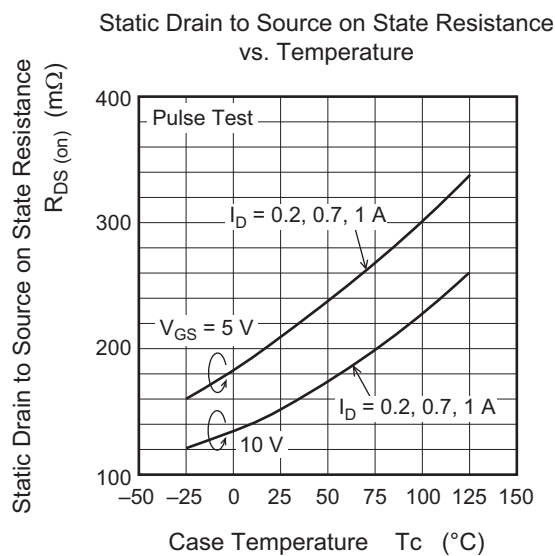


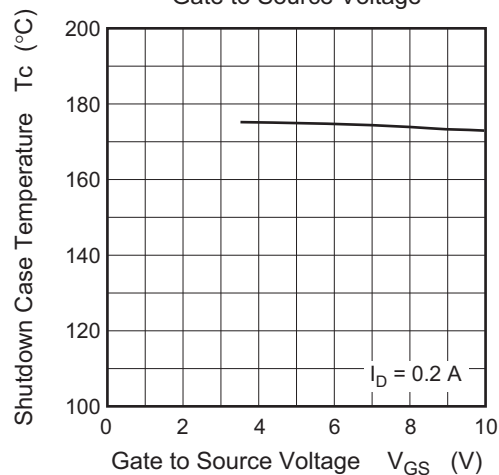
Drain to Source Saturation Voltage vs. Gate to Source Voltage



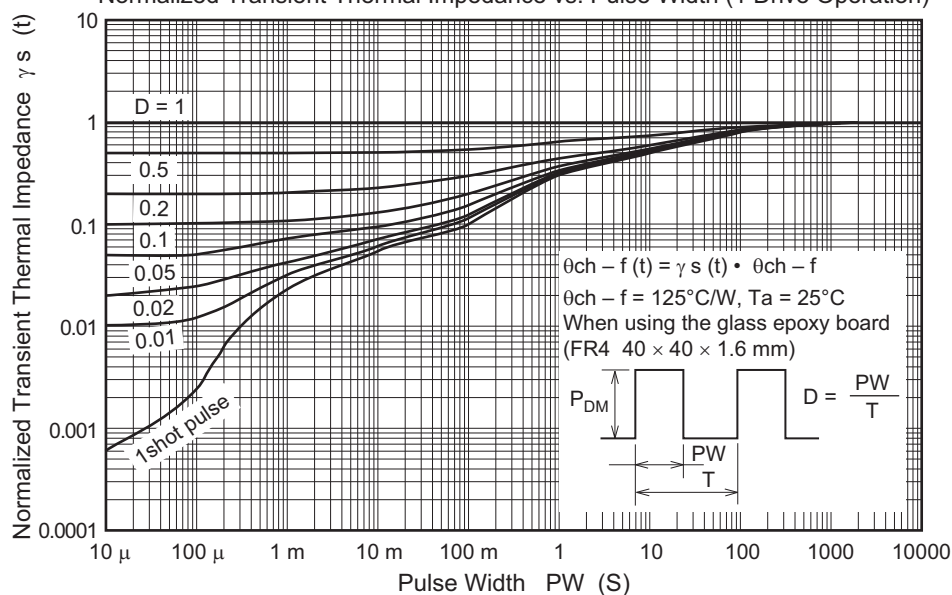
Static Drain to Source on State Resistance vs. Drain Current



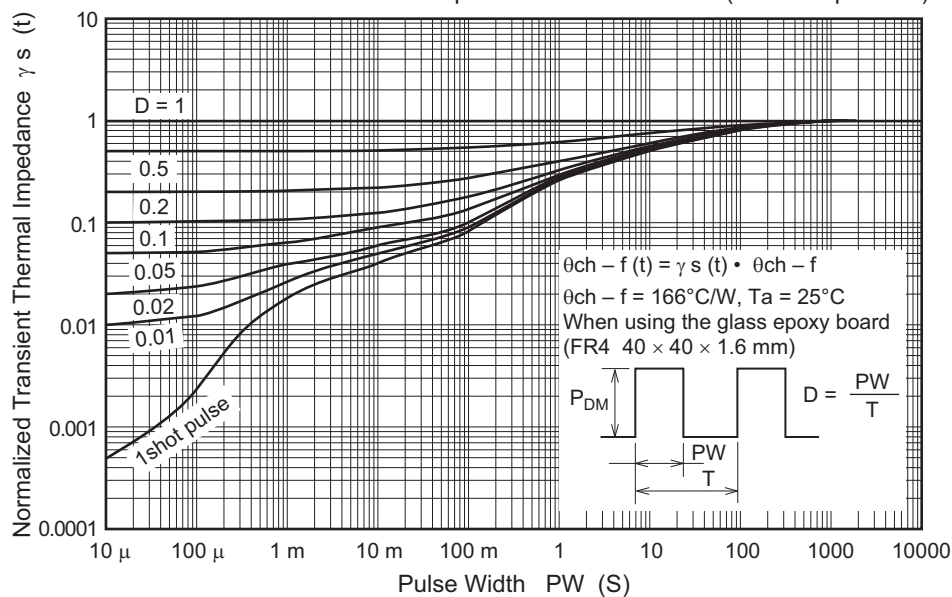


Shutdown Case Temperature vs.  
Gate to Source Voltage

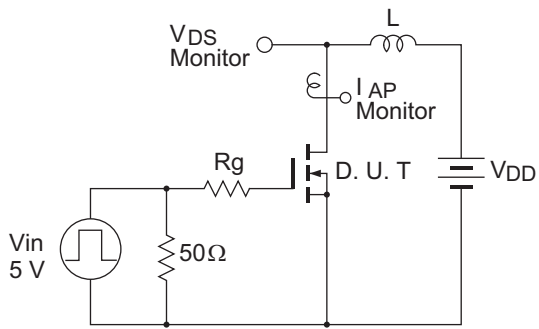
Normalized Transient Thermal Impedance vs. Pulse Width (1 Drive Operation)



Normalized Transient Thermal Impedance vs. Pulse Width (2 Drive Operation)

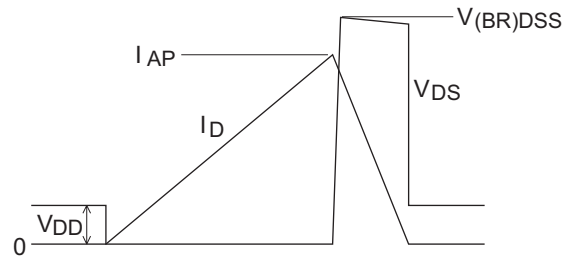


Avalanche Test Circuit

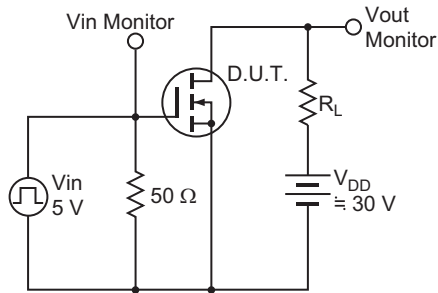


Avalanche Waveform

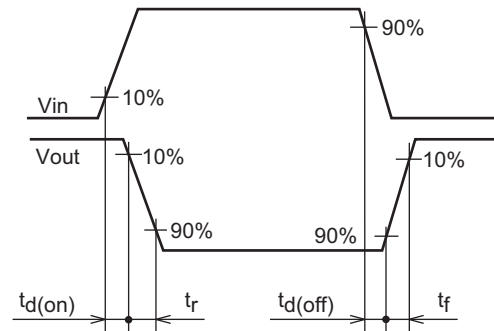
$$E_{AR} = \frac{1}{2} \cdot L \cdot I_{AP}^2 \cdot \frac{V_{DSS}}{V_{DSS} - V_{DD}}$$



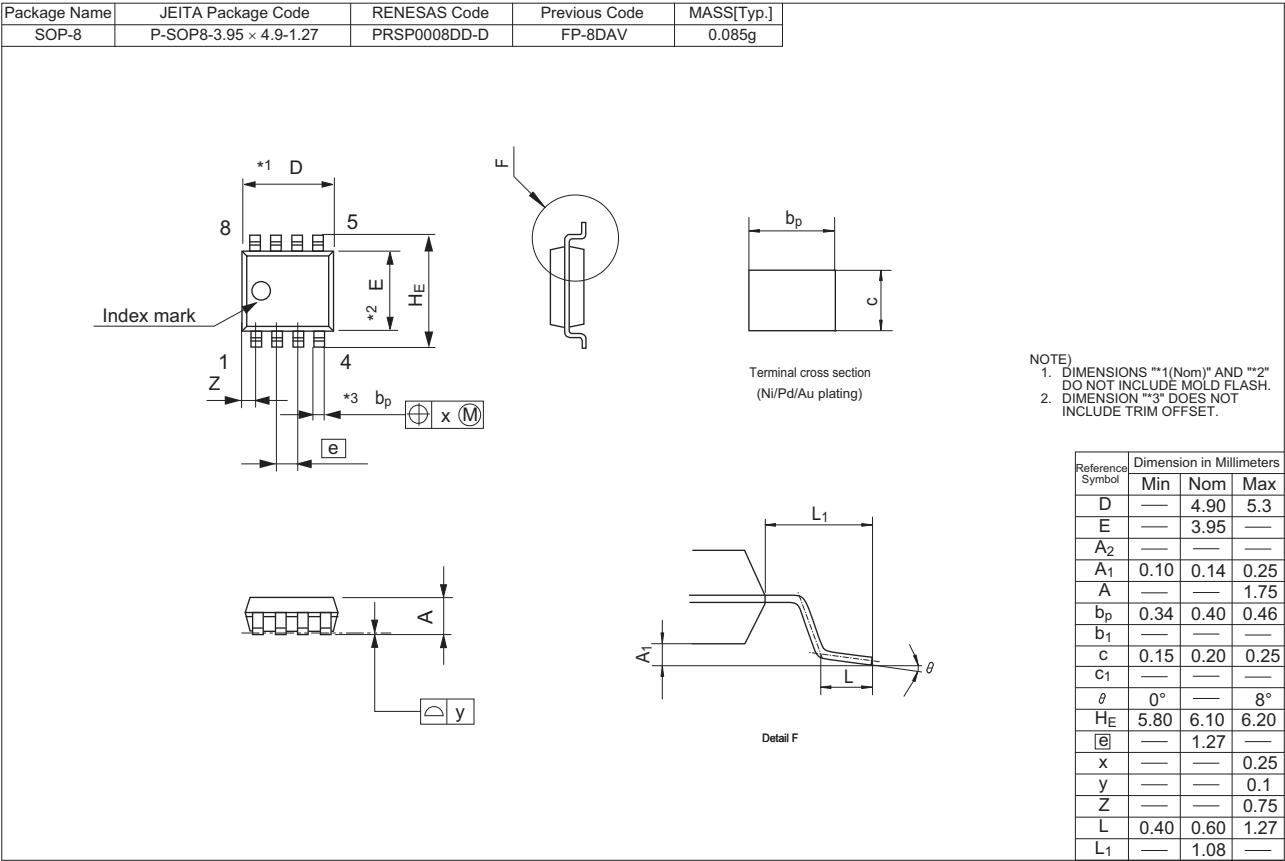
Switching Time Test Circuit



Waveform



Package Dimensions



Ordering Information

| Orderable Part Number | Quantity | Shipping Container |
|-----------------------|----------|--------------------|
| RJF0610JSP-00#J0      | 2500 pcs | Taping (Reel)      |

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